

### General Description

- DCX4710H is best suited for applications where the load needs to be turned on and off using micro-controllers, comparators or other control circuits particularly at a point of load. It features a discrete pre-biased PNP transistor which can support continuous maximum current of 100 mA. It also contains a pre-biased NPN transistor which can be used as a control and can be biased using a higher supply. The component devices can be used as a part of circuit or as stand alone discrete devices.

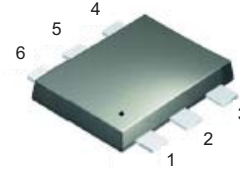


Fig. 1: SOT-563

### Features

- Built in Biasing Resistors
- Epitaxial Planar Die Construction
- Ideally Suited for Automated Assembly Processes
- Lead Free By Design/ROHS Compliant (Note 1)**
- "Green" Device (Note 2)**

### Mechanical Data

- Case: SOT-563
- Case Material: Molded Plastic. "Green Molding" Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020C
- Terminal Connections: See Fig. 2
- Terminals: Finish - Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Marking & Type Code Information: See Page 7
- Ordering Information: See Page 7
- Weight: 0.005 grams (approximate)

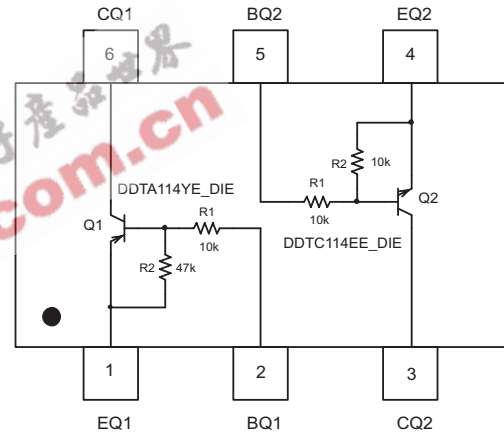


Fig. 2: Schematic and Pin Configuration

Sub-Component P/N	Reference	Device Type	R1 (NOM)	R2 (NOM)	Figure
DDTA114YE_DIE	Q1	PNP	10KΩ	47KΩ	2
DDTC114EE_DIE	Q2	NPN	10KΩ	10KΩ	2

### Maximum Ratings: Total Device @ T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 3)	P <sub>d</sub>	150	mW
Power Derating Factor above 45°C	P <sub>der</sub>	1.43	mW/°C
Output Current	I <sub>out</sub>	100	mA

### Thermal Characteristics @ T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Junction Operation and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 to +150	°C
Thermal Resistance, Junction to Ambient Air (Note 3) (Equivalent to one heated junction of PNP transistor)	R <sub>θJA</sub>	833	°C/W

- Notes:
- No purposefully added lead.
  - Diodes Inc.'s "Green" policy can be found on our website at [http://www.diodes.com/products/lead\\_free/index.php](http://www.diodes.com/products/lead_free/index.php).
  - Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch; as per Diodes Inc. suggested pad layout document AP02001 on our website at <http://www.diodes.com/datasheets/ap02001.pdf>.

**Sub-Component Device - Pre-Biased PNP Transistor (Q1) @ T<sub>A</sub> = 25°C unless otherwise specified**

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V <sub>CB0</sub>	-50	V
Collector-Emitter Voltage	V <sub>CEO</sub>	-50	V
Supply Voltage	V <sub>CC</sub>	-50	V
Input Voltage	V <sub>IN</sub>	+6 to -40	V
Output Current (dc)	I <sub>C(max)</sub>	-100	mA

**Sub-Component Device - Pre-Biased PNP Transistor (Q1) @ T<sub>A</sub> = 25°C unless otherwise specified**

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V <sub>CB0</sub>	50	V
Collector-Emitter Voltage	V <sub>CEO</sub>	50	V
Supply Voltage	V <sub>CC</sub>	50	V
Input Voltage	V <sub>IN</sub>	-10 to +40	V
Output Current (dc)	I <sub>C(max)</sub>	100	mA

**Electrical Characteristics: Pre-Biased PNP Transistor (Q1) @ T<sub>A</sub> = 25°C unless otherwise specified**

Characteristic	Symbol	Min	Typ	Max	Unit	Test Conditions
<b>OFF CHARACTERISTICS</b>						
Collector-Base Cut Off Current	I <sub>CB0</sub>	—	—	-100	nA	V <sub>CB</sub> = -50V, I <sub>E</sub> = 0
Collector-Emitter Cut Off Current	I <sub>CEO</sub>	—	—	-1	μA	V <sub>CE</sub> = -50V, I <sub>B</sub> = 0
Emitter-Base Cut Off Current	I <sub>EBO</sub>	—	—	-500	μA	V <sub>EB</sub> = -5V, I <sub>C</sub> = 0
Collector-Base Breakdown Voltage	V <sub>(BR)CB0</sub>	-50	—	—	V	I <sub>C</sub> = -10 μA, I <sub>E</sub> = 0
Collector-Emitter Breakdown Voltage	V <sub>(BR)CEO</sub>	-50	—	—	V	I <sub>C</sub> = -2 mA, I <sub>B</sub> = 0
Output Off Voltage	V <sub>OH</sub>	-4.6	—	—	V	V <sub>CC</sub> = -5V, V <sub>B</sub> = -0.05V, R <sub>L</sub> = 1KΩ
Input Off Voltage	V <sub>I(OFF)</sub>	—	-0.71	-0.5	V	V <sub>CE</sub> = -5V, I <sub>C</sub> = -100μA
Output Off Current	I <sub>O(OFF)</sub>	—	—	-1	μA	V <sub>CC</sub> = -50V, V <sub>I</sub> = 0V
<b>ON CHARACTERISTICS</b>						
Collector-Emitter Saturation Voltage	V <sub>CE(SAT)</sub>	—	-0.066	-0.1	V	I <sub>C</sub> = 5 mA, I <sub>B</sub> = -0.25 mA
		—	-0.078	-0.1		I <sub>C</sub> = -10mA, I <sub>B</sub> = -0.3mA
		—	-0.06	-0.1		I <sub>C</sub> = -10mA, I <sub>B</sub> = -1mA
		—	-0.04	-0.1		I <sub>C</sub> = -10mA, I <sub>B</sub> = -5mA
		—	-0.99	-1.15		I <sub>C</sub> = -100mA, I <sub>B</sub> = -5mA
		—	0.99	-1.15		I <sub>C</sub> = -100mA, I <sub>B</sub> = -10mA
Equivalent on-resistance*	R <sub>CE(SAT)</sub>	—	—	3.5	Ω	I <sub>C</sub> = -100mA, I <sub>B</sub> = -10mA
DC Current Gain	h <sub>FE</sub>	50	—	—	—	V <sub>CE</sub> = -5V, I <sub>C</sub> = -1 mA
		130	—	—	—	V <sub>CE</sub> = -5V, I <sub>C</sub> = -5 mA
		180	—	—	—	V <sub>CE</sub> = -5V, I <sub>C</sub> = -50 mA
		100	—	—	—	V <sub>CE</sub> = -5V, I <sub>C</sub> = -100 mA
		140	—	—	—	V <sub>CE</sub> = -10V, I <sub>C</sub> = -5 mA
Output On Voltage	V <sub>OL</sub>	—	-0.185	-0.22	V	V <sub>CC</sub> = -5V, V <sub>B</sub> = -2.5V, R <sub>L</sub> = 1KΩ
Input On Voltage (Load is on)	V <sub>I(ON)</sub>	-1.25	-0.9	—	V	V <sub>O</sub> = -0.3V, I <sub>C</sub> = -2 mA
Input Current	I <sub>i</sub>	—	—	-0.88	mA	V <sub>I</sub> = -5V
Base-Emitter Turn-on Voltage	V <sub>BE(ON)</sub>	—	-0.72	-0.8	V	V <sub>CE</sub> = -5V, I <sub>C</sub> = 100μA
Base-Emitter Saturation Voltage	V <sub>BE(SAT)</sub>	—	-1.15	-1.25	V	I <sub>C</sub> = 1mA, I <sub>B</sub> = 50μA
Input Resistor +/- 30% (Base)	ΔR1	7	10	13	KΩ	—
Pull-up Resistor (Base to V <sub>CC</sub> supply)	R2	32	47	62	KΩ	—
Resistor Ratio	Δ(R2/R1)	20	—	20	%	—

**Electrical Characteristics: Pre-Biased PNP Transistor (Q1) (Continued)**

SMALL SIGNAL CHARACTERISTICS						
Transition Frequency (gain bandwidth product)	$f_T$	—	200	—	MHz	$V_{CE} = -10V, I_E = -5mA, f = 100MHz$
Collector capacitance (C <sub>cb</sub> -Output Capacitance)	$C_C$	—	5	—	pF	$V_{CB} = -10V, I_E = 0A, f = 1MHz$

\*Pulse Test: Pulse width,  $t_p < 300 \mu s$ , Duty Cycle,  $d < 0.02$

**Pre-Biased NPN Transistor (Q2) @  $T_A = 25^\circ C$  unless otherwise specified**

Characteristic	Symbol	Min	Typ	Max	Unit	Test Conditions
<b>OFF CHARACTERISTICS</b>						
Collector-Base Cut Off Current	$I_{CBO}$	—	—	100	nA	$V_{CB} = 50V, I_E = 0$
Collector-Emitter Cut Off Current	$I_{CEO}$	—	—	1	$\mu A$	$V_{CE} = 50V, I_B = 0$
Emitter-Base Cut Off Current	$I_{EBO}$	—	—	500	$\mu A$	$V_{EB} = 5V, I_C = 0$
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	50	—	—	V	$I_C = 10 \mu A, I_E = 0$
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	50	—	—	V	$I_C = 2 mA, I_B = 0$
Output Off Voltage	$V_{OH}$	4.6	—	—	V	$V_{CC} = 5V, V_B = 0.05V, R_L = 1K\Omega$
Input Off Voltage	$V_{I(OFF)}$	—	1.2	0.8	V	$V_{CE} = 5V, I_C = 100\mu A$
Output Current	$I_{O(OFF)}$	—	—	1	$\mu A$	$V_{CC} = 50V, V_I = 0V$
<b>ON CHARACTERISTICS</b>						
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$	—	0.06	0.1	V	$I_C = 5 mA, I_B = 0.25 mA$
		—	0.06	0.1		$I_C = 10mA, I_B = 0.5mA$
		—	0.042	0.06		$I_C = 10mA, I_B = 1mA$
		—	0.026	0.04		$I_C = 10mA, I_B = 5mA$
		—	0.272	0.35		$I_C = 100mA, I_B = 5mA$
		—	0.28	0.35		$I_C = 100mA, I_B = 10mA$
Equivalent on-resistance*	$R_{CE(SAT)}$	—	—	3.5	$\Omega$	$I_C = 100mA, I_B = 10mA$
DC Current Gain	$h_{FE}$	12	—	—	—	$V_{CE} = 5V, I_C = 1 mA$
		45	—	—	—	$V_{CE} = 5V, I_C = 5 mA$
		130	—	—	—	$V_{CE} = 5V, I_C = 50 mA$
		70	—	—	—	$V_{CE} = 5V, I_C = 100 mA$
		40	58	—	—	$V_{CE} = 10V, I_C = 5 mA$
Output On Voltage	$V_{OL}$	—	0.12	0.2	V	$V_{CC} = 5V, V_B = 2.5V, R_L = 1K\Omega$
Input On Voltage	$V_{I(ON)}$	2.8	1.6	—	V	$V_O = 0.3V, I_C = 2 mA$
Input Current	$I_i$	—	—	0.88	mA	$V_I = 5V$
Base-Emitter Turn-on Voltage	$V_{BE(ON)}$	—	—	1.195	V	$V_{CE} = 5V, I_C = 100\mu A$
Base-Emitter Saturation Voltage	$V_{BE(SAT)}$	—	—	1.02	V	$I_C = 1mA, I_B = 50\mu A$
Input Resistor +/- 30% (Base)	R1	7	10	13	K $\Omega$	—
Resistor Ratio	(R2/R1)	0.8	1	1.2	—	—
<b>SMALL SIGNAL CHARACTERISTICS</b>						
Transition Frequency (Gain bandwidth product)	$f_T$	—	250	—	MHz	$V_{CE} = 10V, I_E = 5mA, f = 100MHz$
Collector capacitance (C <sub>cb</sub> -Output Capacitance)	$C_C$	—	4	—	pF	$V_{CB} = 10V, I_E = 0A, f = 1MHz$

\*Pulse Test: Pulse width,  $t_p < 300 \mu s$ , Duty Cycle,  $d < 0.02$

**Typical Characteristics** @  $T_{amb} = 25^{\circ}\text{C}$  unless otherwise specified

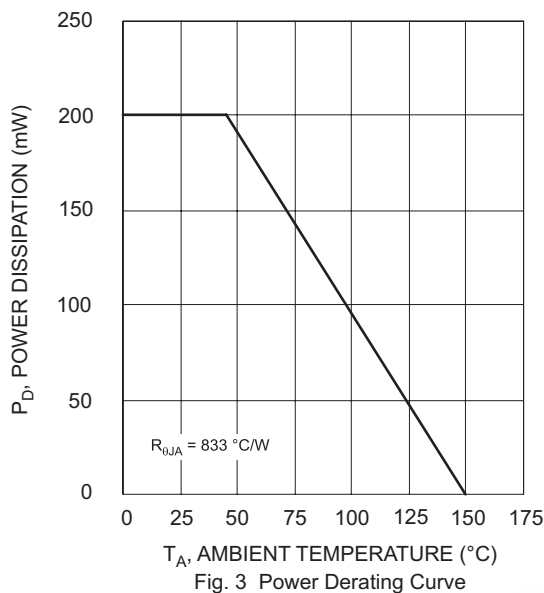


Fig. 3 Power Derating Curve

**Characteristics Curves of PNP Transistor (Q1)** @  $T_{amb} = 25^{\circ}\text{C}$  unless otherwise specified

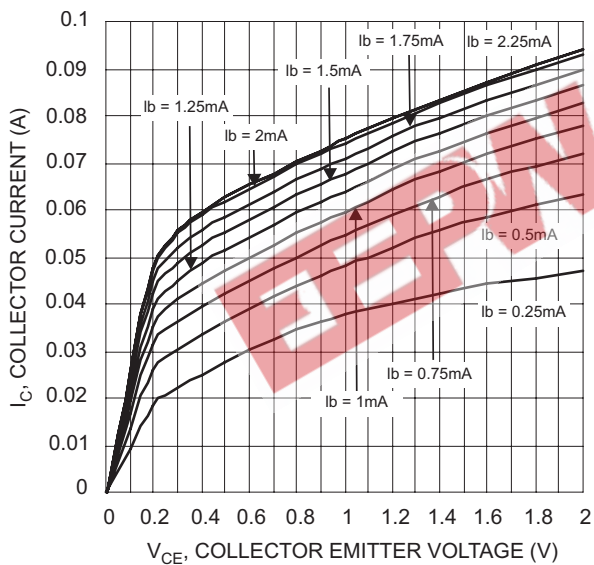


Fig. 4  $V_{CE}$  vs.  $I_C$

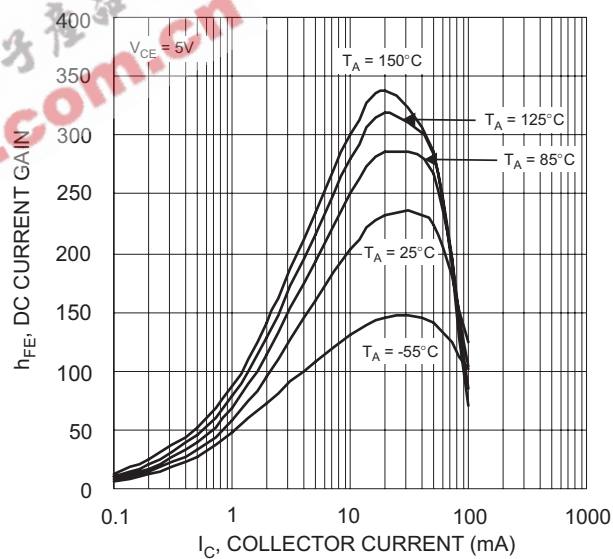


Fig. 5 DC Current Gain vs.  $I_C$

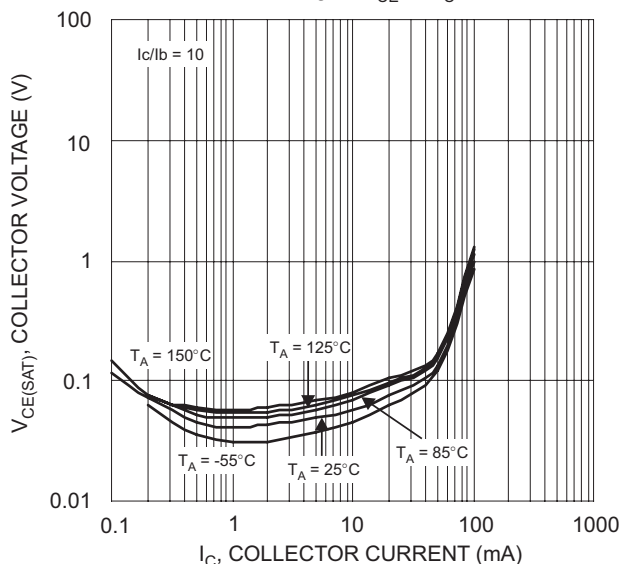


Fig. 6  $I_C$  vs.  $V_{CE(SAT)}$

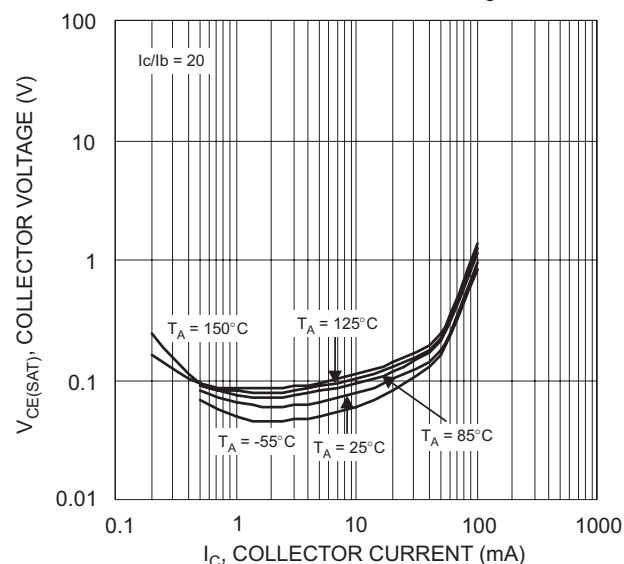


Fig. 7  $I_C$  vs.  $V_{CE(SAT)}$

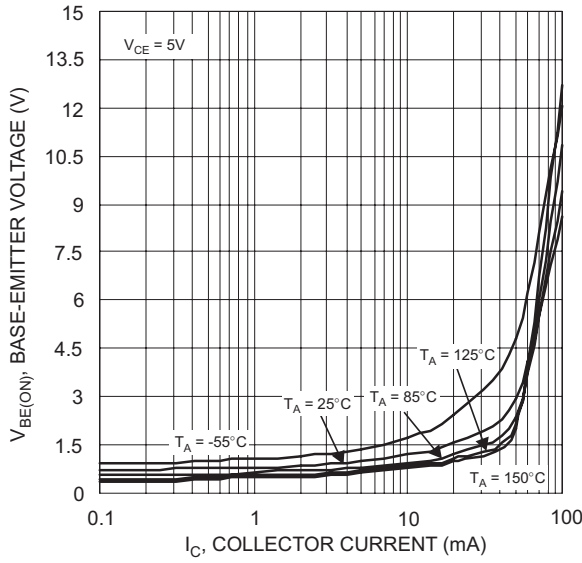


Fig. 8  $I_C$  vs.  $V_{BE(ON)}$

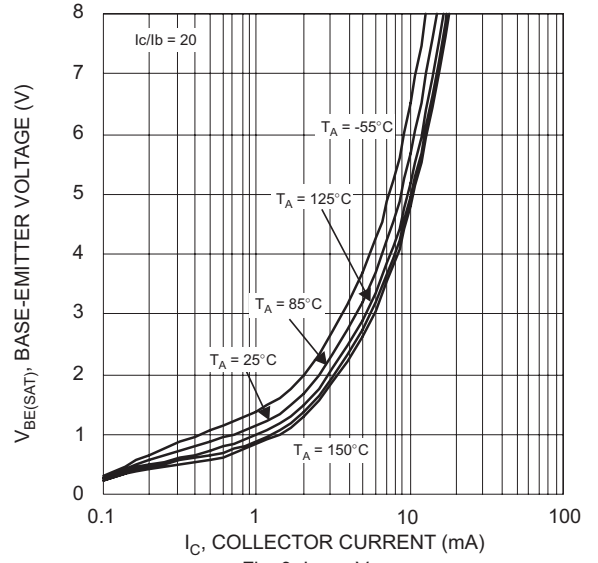


Fig. 9  $I_C$  vs.  $V_{BE(SAT)}$

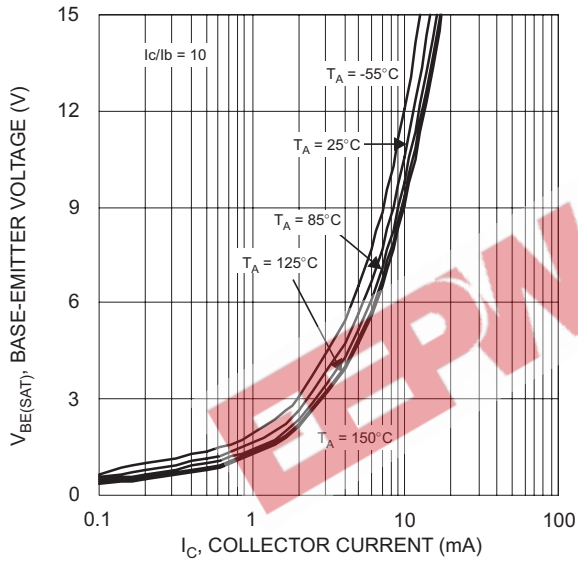


Fig. 10  $I_C$  vs.  $V_{BE(SAT)}$

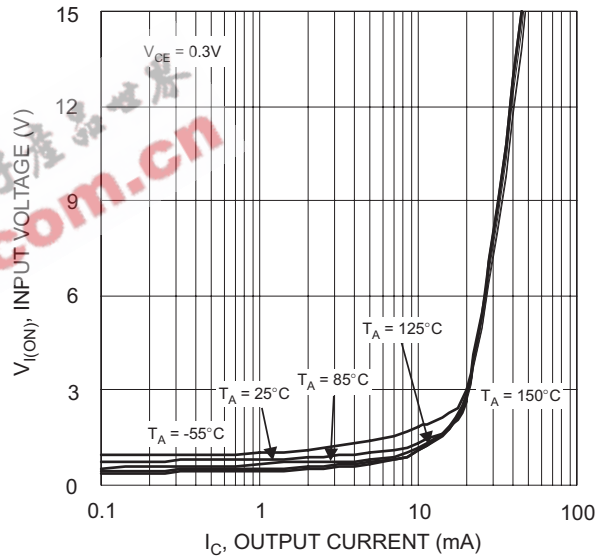


Fig. 11 Input Voltage vs. Collector Current

**Characteristics Curves of NPN Transistor (Q2)** @  $T_{amb} = 25^\circ C$  unless otherwise specified

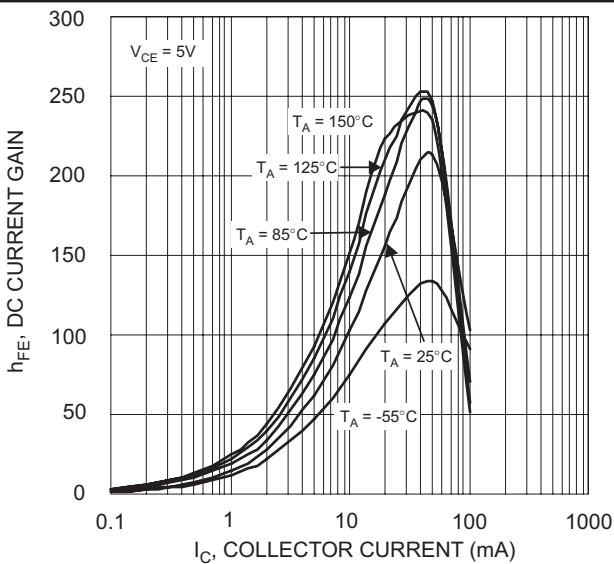


Fig. 12 DC Current Gain vs.  $I_C$

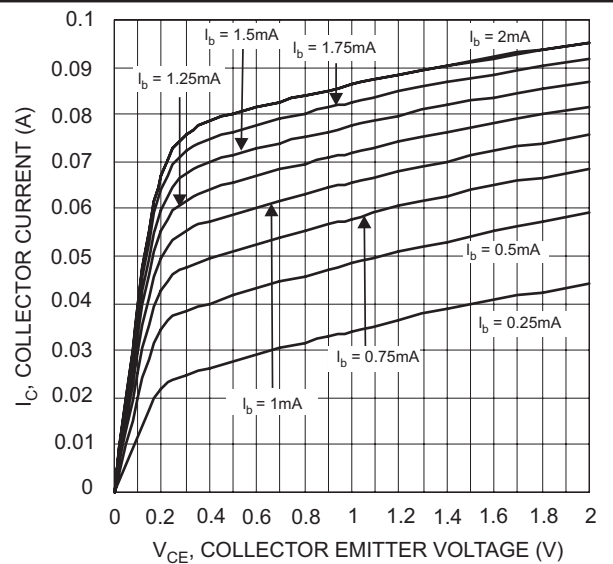


Fig. 13  $V_{CE}$  vs.  $I_C$

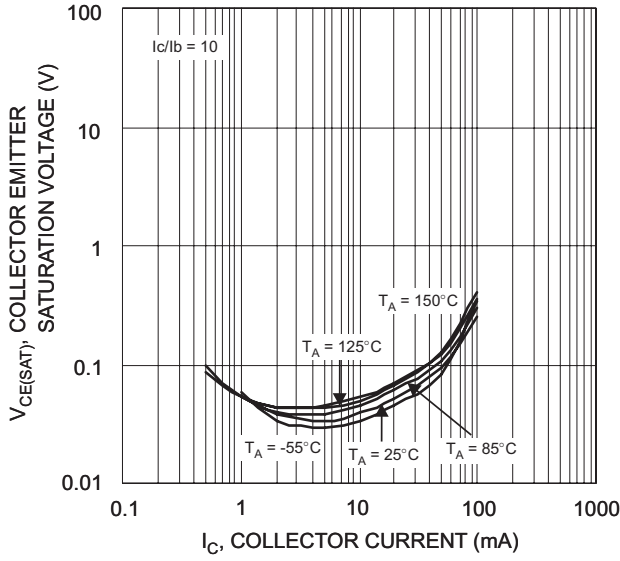


Fig. 14  $I_C$  vs.  $V_{CE(SAT)}$

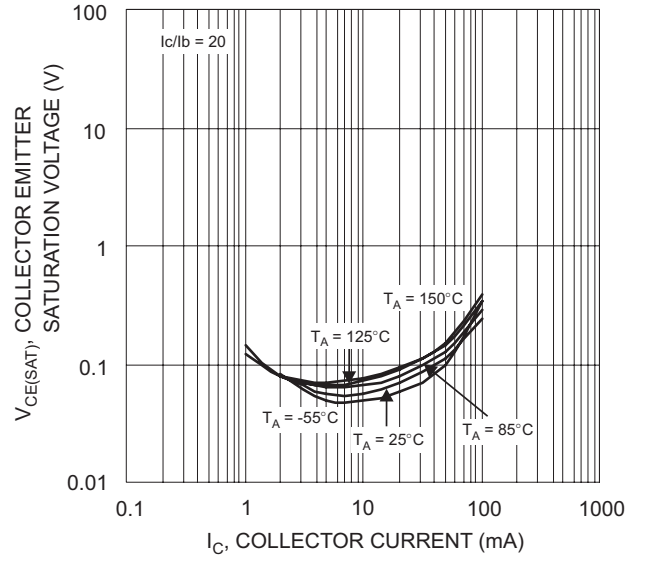


Fig. 15  $I_C$  vs.  $V_{CE(SAT)}$

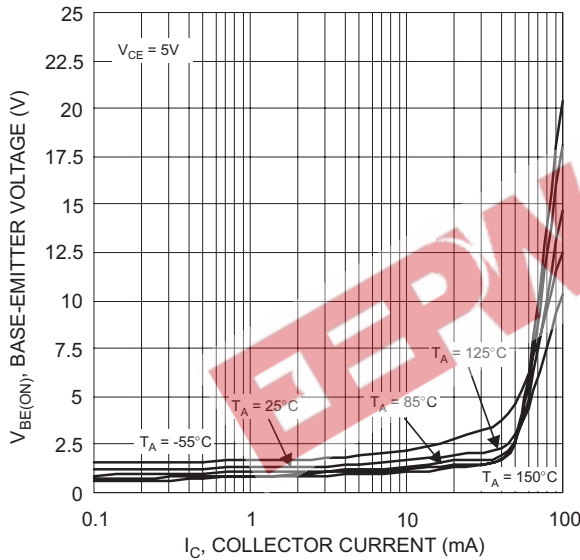


Fig. 16  $I_C$  vs.  $V_{BE(ON)}$

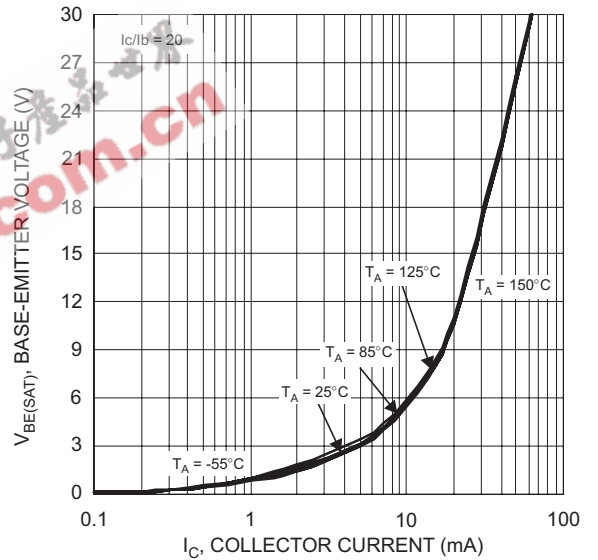


Fig. 17  $I_C$  vs.  $V_{BE(SAT)}$

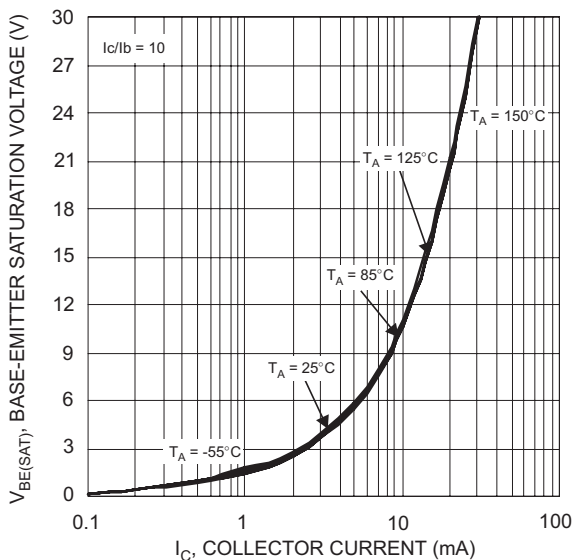


Fig. 18  $I_C$  vs.  $V_{BE(SAT)}$

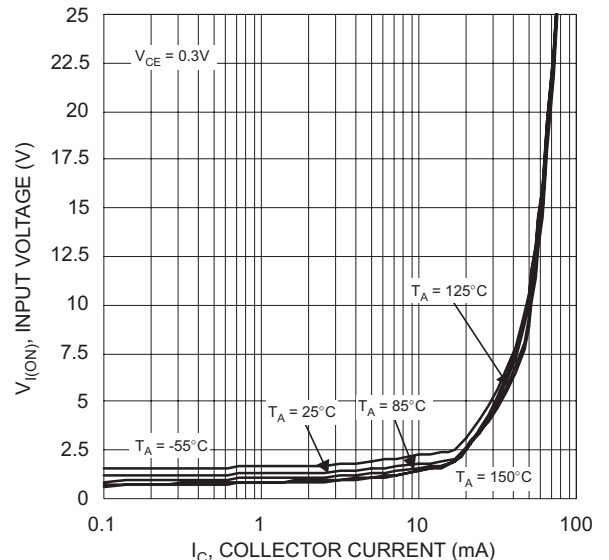


Fig. 19 Input Voltage vs. Output Current

**Ordering Information** (Note 5)

Device	Marking Code	Packaging	Shipping
DCX4710H-7	C02	SOT-563	3000/Tape & Reel

Notes: 5. For Packaging Details, go to our website at <http://www.diodes.com/datasheets/ap02007.pdf>.

**Marking Information**

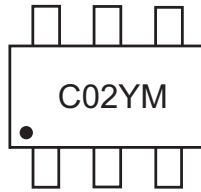
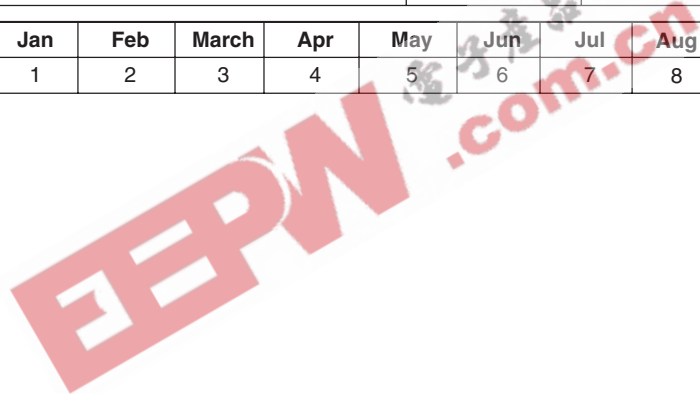


Fig. 20

C02 = Product Type Marking Code  
 YM = Date Code Marking  
 Y = Year e.g., T = 2006  
 M = Month e.g., 9 = September

Date Code Key

Year		2006		2007		2008		2009				
Code		T		U		V		W				
Month	Jan	Feb	March	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D



**Mechanical Details**

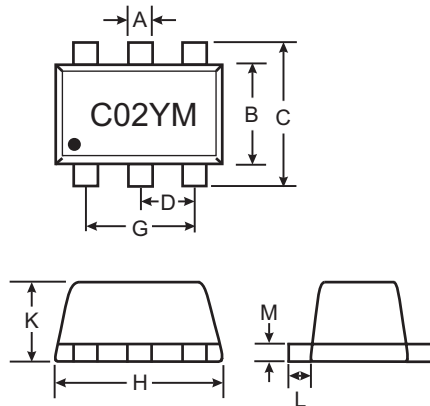


Fig. 21

SOT-563			
Dim	Min	Max	Typ
A	0.15	0.3	0.25
B	1.1	1.25	1.2
C	1.55	1.7	1.6
D	0.5		
G	0.9	1.1	1
H	1.5	1.7	1.6
K	0.56	0.6	0.6
L	0.15	0.25	0.2
M	0.1	0.18	0.11
All Dimensions in mm			

Suggested Pad Layout: (Based on IPC-SM-782)

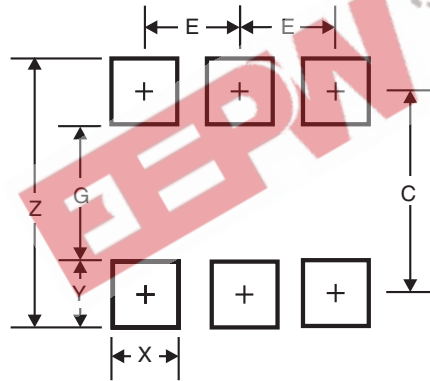


Fig. 22

Figure 4 Dimensions	SOT-563
Z	2.2
G	1.2
X	0.375
Y	0.5
C	1.7
E	0.5

**IMPORTANT NOTICE**

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to any product herein. Diodes Incorporated does not assume any liability arising out of the application or use of any product described herein; neither does it convey any license under its patent rights, nor the rights of others. The user of products in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on our website, harmless against all damages.

**LIFE SUPPORT**

Diodes Incorporated products are not authorized for use as critical components in life support devices or systems without the expressed written approval of the President of Diodes incorporated.